DISCRETE SEMICONDUCTORS

DATA SHEET



BAS86Schottky barrier diode

Product data sheet Supersedes data of 1996 Oct 01 2000 May 25



Schottky barrier diode

BAS86

FEATURES

- Low forward voltage
- · High breakdown voltage
- · Guard ring protected
- Hermetically-sealed small SMD package.

APPLICATIONS

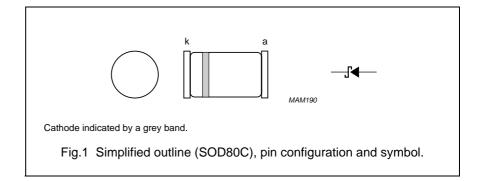
- · Ultra high-speed switching
- · Voltage clamping
- · Protection circuits
- · Blocking diodes.

DESCRIPTION

Planar Schottky barrier diode with an integrated protection ring against static discharges.

This surface mounted diode is encapsulated in a hermetically sealed

SOD80C glass SMD package with tin-plated metal discs at each end. It is suitable for "automatic placement" and as such it can withstand immersion soldering.



LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _R	continuous reverse voltage		_	50	V
I _F	continuous forward current		-	200	mA
I _{F(AV)}	average forward current	see Fig.2	_	200	mA
I _{FRM}	repetitive peak forward current	$t_p \le 1$ sec.; $\delta \le 0.5$	_	500	mA
I _{FSM}	non-repetitive peak forward current	t _p = 10 ms	_	5	Α
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	125	°C
T _{amb}	operating ambient temperature		-65	+125	°C

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ELECTRICAL CHARACTERISTICS

 T_{amb} = 25 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT
V _F	forward voltage	see Fig.3		
		$I_F = 0.1 \text{ mA}$	300	mV
		I _F = 1 mA	380	mV
		I _F = 10 mA	450	mV
		I _F = 30 mA	600	mV
		I _F = 100 mA	900	mV
I _R	reverse current	V _R = 40 V; see Fig.4; note 1	5	μΑ
t _{rr}	reverse recovery time	when switched from I_F = 10 mA to I_R = 10 mA; R_L = 100 Ω ; measured at I_R = 1 mA; see Fig.6	4	ns
C _d	diode capacitance	f = 1 MHz; V _R = 1 V; see Fig.5	8	pF

Note

1. Pulsed test: t_p = 300 μ s; δ = 0.02.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	note 1	320	K/W

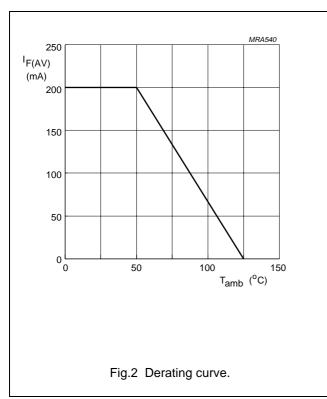
Note

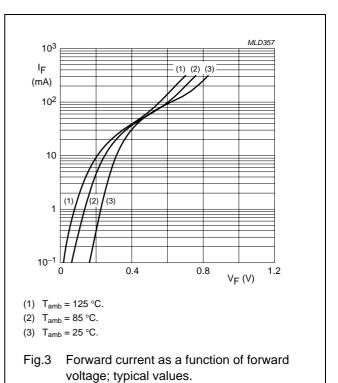
1. Refer to SOD80 standard mounting conditions.

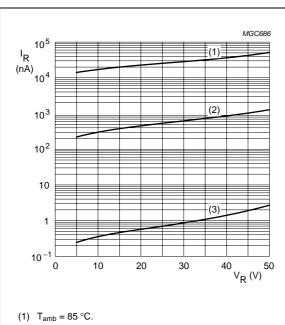
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GRAPHICAL DATA

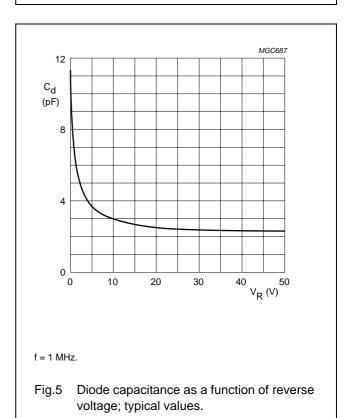






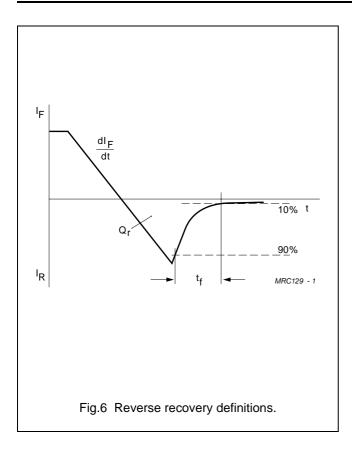
- (2) $T_{amb} = 25 \,^{\circ}C$.
- (3) $T_{amb} = -40 \, ^{\circ}C$.

Fig.4 Reverse current as a function of reverse voltage; typical values.



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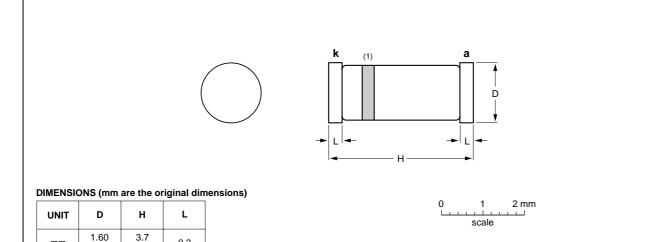
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PACKAGE OUTLINE

Hermetically sealed glass surface mounted package; 2 connectors

SOD80C



Note

 $\mathsf{m}\mathsf{m}$

1. The marking band indicates the cathode.

0.3

OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOD80C	100H01					97-06-20

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DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

Notes

- 1. Please consult the most recently issued document before initiating or completing a design.
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2000 May 25

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Customer notification

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Contact information

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